TELECOMMUNICATION
STANDARDIZATION SECTOR
OF ITU

Q.135

SPECIFICATIONS OF SIGNALLING SYSTEM No. 4

PRINCIPLES OF RAPID TRANSMISSION TESTING EQUIPMENT

ITU-T Recommendation Q.135

(Extract from the Blue Book)

NOTES

1	ITU-T Reco	mmendation Q.1	35 was pu	ıblished in	Fascicle '	VI.2 of the	e Blue	Book.	This file	e is an	extract	from
the Blue	Book. While	the presentation	and layout	of the tex	t might be	e slightly o	lifferen	t from	the Blu	e Bool	k versioi	n, the
contents	of the file are	identical to the	Blue Book	version and	d copyrigh	nt conditio	ns rema	ain unc	hanged	(see be	elow).	

2	In this	Recommendation,	the	expression	"Administration"	is	used	for	conciseness	to	indicate	both	8
telecommunication administration and a recognized operating agency.													

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Recommendation Q.135

5.3 PRINCIPLES OF RAPID TRANSMISSION TESTING EQUIPMENT

Rapid transmission tests can be made by two methods:

- a) The first method consists of a loop measurement of the GO and RETURN paths of an international circuit, these paths being looped at the incoming end of a circuit when it is free.
- b) The second method consists of sending a special code on the international circuit to be tested so as to obtain access to an automatic testing equipment in the incoming exchange.

The first method requires that the incoming end of all circuits should be equipped as described later in Recommendation Q.136.

The second method assumes the existence of rapid transmission testing equipment in all exchanges between which this method is used. This testing equipment must be designed in accordance with Recommendation Q.137.

Note - The first method provides overall testing on the GO and RETURN paths without being able to differentiate between the conditions of each of the two directions of transmission. The second method enables separate transmission tests in the two directions. (A situation can occur, however, when it is not possible to determine whether a transmission fault is on the GO path or on the RETURN path of the circuit.) Since the second method requires that for access to the incoming testing apparatus signals must be passed over the circuit, there is some check of good signalling conditions.